·	Application No.	Applicant(s)	
Notice of Allowability	10/722,490	ISHIBASHI ET AL.	m
	Examiner	Art Unit	
	Rene Garcia, Jr.	2853	
	Nelle Galdia, Jl.	2000	:
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIG	(OR REMAINS) CLOSED in this or other appropriate communica GHTS. This application is subjection	s application. If not include ation will be mailed in due	ed course. THIS
1. This communication is responsive to <u>9 December 2005</u> .			
2. X The allowed claim(s) is/are <u>1-4,6-10 and 12-38</u> .			
 3. Acknowledgment is made of a claim for foreign priority un a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents 	been received. been received in Application N	0	tion from the
International Bureau (PCT Rule 17.2(a)).			
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		eply complying with the rec	uirements
4. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.			
5. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.			
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached			
1) 🔲 hereto or 2) 🔲 to Paper No./Mail Date			
(b) ☐ including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date			
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).			
6. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.			
Attachment(s)			<u>:</u> :
1. Notice of References Cited (PTO-892)	<u> </u>	nal Patent Application (PTC)-152) ·
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6.	nary (PTO-413), I Date .	:
 Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No./Mail Date 6/15/04; 2/27/04 	8), 7. Examiner's Amo	endment/Comment	
4. Examiner's Comment Regarding Requirement for Deposit	8. 🛛 Examiner's Stat	tement of Reasons for Allo	wance
of Biological Material	9. 🗌 Other		:
			:

DETAILED ACTION

Reasons For Allowance

1. Claims 1-4, 6-10, and 12-38 are allowed.

The following is an examiner's statement of reasons for allowance: The primary reason for the allowance of claim 1 is the inclusion of the method step acceptance width is determined from following inequality: [acceptance width]>[line width]/(α [writing density (dpi)]^{- β}). It is these steps found in each of the claims, as they are claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

- 2. The primary reason for the allowance of claim 9 is the inclusion of the method step acceptance width is determined from following inequality: [acceptance width]>[line width]/(α [writing density (dpi)]^{- β}). It is these steps found in each of the claims, as they are claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.
- 3. The primary reason for the allowance of claim 16 is the inclusion of the limitations being for an alignment pattern detecting sensor of an image forming apparatus that includes an acceptance width of the alignment pattern detecting sensor is determined form the following inequality: [acceptance width]>[line width]/(α [writing density (dpi)]^{- β}). It is this limitation found in each of the claims, as they are claimed in the combination, that has not been found,

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taught or suggested by the prior art of record which makes these claims allowable over the prior art.

- 4. The primary reason for the allowance of claim 22 is the inclusion of the limitations being for an image forming apparatus that includes an acceptance width of the alignment pattern detecting sensor is determined form the following inequality: [acceptance width]>[line width]/(α[writing density (dpi)]^{-β}). It is this limitation found in each of the claims, as they are claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.
- 5. The primary reason for the allowance of claim 38 is the inclusion of the limitations being for a computer program that includes an acceptance width of the alignment pattern detecting sensor is determined form the following inequality: [acceptance width]>[line width]/(α [writing density (dpi)]^{- β}). It is this limitation found in each of the claims, as they are claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

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Communications with the USPTO

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Rene Garcia, Jr. whose telephone number is (571) 272-5980. The examiner can normally be reached on M-F 8:00AM - 4:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Stephen D. Meier can be reached on (571) 272-2149. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Rene Garcia Jr 12 January 2006 ACTEGORS EXAMINER